

Notice of References Cited	Application/Control No. 10/757,270	Applicant(s)/Patent Under Reexamination DI LUOFFO ET AL.	
	Examiner Djenane M. Bayard	Art Unit 2141	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,269,757	09-2007	Lieblich et al.	714/37
*	B	US-2003/0126240	07-2003	Vosseler, Frank	709/221
*	C	US-6,594,684	07-2003	Hodjat et al.	709/202
*	D	US-7,086,086	08-2006	Ellis, Alonzo	726/15
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fault-Tolerant Grid Architecture and Practice, July 2003, Vol 18, pp 423-433, J.comput. Sci and Technol, Hai et al
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.